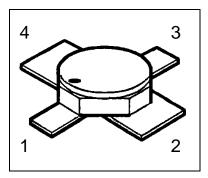


# HiRel NPN Silicon Germanium RF Transistor

- HiRel Discrete and Microwave Semiconductor
- For high power amplifiers
- Ideal for low phase noise oscilators
- Maximum available gain: G<sub>ma</sub> = 19 dB at 1.8 GHz Noise figure F = 0.9 dB at 1.8 GHz
- Hermetically sealed microwave package
- CC Detail Spec. No.: 5611/010

**ESD**: Electrostatic discharge sensitive device, observe handling precautions!



Туре	Marking	Pin Configuration				Package
		1	2	3	4	
BFY650B-11	-	С	Е	В	Е	Micro-X

### **Maximum Ratings**

Parameter	Symbol	Values	Unit	
Collector-emitter voltage $T_a > 0 \ ^{\circ}C$ $T_a \le 0 \ ^{\circ}C$	V <sub>CEO</sub>	4.0 3.7	V V	
Collector-base voltage	V <sub>CBO</sub>	13	V	
Emitter-base voltage	V <sub>EBO</sub>	1.2	V	
Collector current <sup>1)</sup>	Ι <sub>C</sub>	150	mA	
Base current	Ι <sub>Β</sub>	10	mA	
Junction temperature	Tj	175	°C	
Operating temperature range	T <sub>op</sub>	-65+175	°C	
Storage temperature range	T <sub>stg</sub>	-65+175	°C	
Thermal Resistance				
Junction-soldering point <sup>2)</sup>	R <sub>th JS</sub>	150	K/W	

### Notes .:

1) For  $T_S \le 85^{\circ}$ C. For  $T_S > 85^{\circ}$ C derating is required.

2)  $T_S$  is measured on the emitter lead at the soldering point to the pcb.

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## **Electrical Characteristics**

at T<sub>A</sub>=25°C; unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics				•	
Collector-base cutoff current	I <sub>CBO</sub>	-	-	10	μA
$V_{CB} = 5 \text{ V}, \text{ I}_{E} = 0$					
Collector-emitter cutoff current <sup>1)</sup>	I <sub>CEX</sub>	-	-	200	μA
$V_{CE} = 4.0 \text{ V}, \text{ I}_{B} = 0.1  \mu\text{A}$					
Emitter-base cuttoff current	I <sub>EBO</sub>	-	-	10	μA
$V_{EB} = 1.2 \text{ V}, I_{C} = 0$					
DC current gain	h <sub>FE</sub>	110	180	270	-
$I_{\rm C}$ = 80 mA, $V_{\rm CE}$ = 3 V					
AC Characteristics				•	
Collector-base capacitance	C <sub>CB</sub>	-	0.26	-	pF
$V_{CB} = 2 V$ , $V_{BE} = vbe = 0$ , f = 1 MHz					
Collector-emitter capacitance	C <sub>CE</sub>	-	0.55	-	pF
$V_{CE} = 2 V$ , $V_{BE} = vbe = 0$ , f = 1 MHz					
Emitter-base capacitance	C <sub>EB</sub>	-	1.4	-	pF
$V_{\text{EB}} = 0.5V, V_{\text{CB}} = vcb = 0, f = 1 \text{ MHz}$					
Noise Figure ( $Z_S = Z_{sopt}$ )	F				dB
$I_{\rm C}$ = 10 mA, $V_{\rm CE}$ = 3 V, f = 1.8 GHz		-	0.9	-	
$I_{C} = 10 \text{ mA}, V_{CE} = 3 \text{ V}, f = 6.0 \text{ GHz}$		-	1.4	-	
Insertion power gain ( $Z_S = Z_L = 50 \Omega$ )	S <sub>21e</sub>   <sup>2</sup>				dB
$I_{c} = 80 \text{ mA}, V_{cE} = 3 \text{ V}, f = 1.8 \text{ GHz}$		-	16.5 6.7	-	
$I_{c} = 80 \text{ mA}, V_{CE} = 3 \text{ V}, f = 6.0 \text{ GHz}$	<b>C</b> <sup>2)</sup>	-	0.7		dD
Power gain ( $Z_S = Z_{Sopt}$ , $Z_L = Z_{Lopt}$ )	G <sub>ma</sub> <sup>2)</sup>	-	19.2	-	dB
$I_{C} = 80 \text{ mA}, V_{CE} = 3 \text{ V}, f = 1.8 \text{ GHz}$	2)				
Power gain ( $Z_S = Z_{Sopt}$ , $Z_L = Z_{Lopt}$ )	G <sub>ma</sub> <sup>2)</sup>	-	9.3	-	dB
$I_{C} = 80 \text{ mA}, V_{CE} = 3 \text{ V}, \text{ f} = 6.0 \text{ GHz}$					

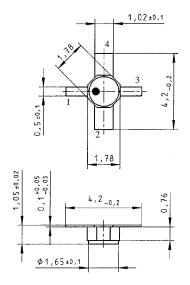
Notes.: 1) This Test assures V(BR)CE0 > 4.0V

2) 
$$G_{ma} = \left| \frac{S21}{S12} \right| (k - \sqrt{k^2 - 1}), \quad G_{ms} = \left| \frac{S21}{S12} \right|$$

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## Micro-X Package



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